Application/Control No.	Applicant(s)/Patent under Reexamination	
10/710,307	BONALLE ET AL.	
Examiner	Art Unit	
Daniel I. Walsh	2876	

Daniel I. Walsh

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Class .	Subclass	Date	Examiner
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
		DATE	EXMR
EAST search attached		4/25/2006	DW
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